## Notice of References Cited Application/Control No. 10/626,717 Examiner Jehanne S. Sitton Applicant(s)/Patent Under Reexamination ANDERSEN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,582,908	06-2003	Fodor et al.	435/6
*	В	US-5,474,796	12-1995	Brennan, Thomas M.	427/2.13
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	1991 Sigma Catalog, pages 747, 749
	V	Skolnick and Fetrow, TIBTECH, January 2000, vol. 18, pp 34-39
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.